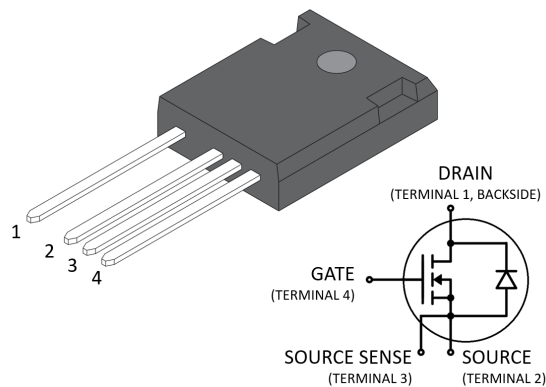


MSC035SMA070B4 Silicon Carbide N-Channel Power MOSFET

Product Overview

The silicon carbide (SiC) power MOSFET product line from Microsemi increases the performance over silicon MOSFET and silicon IGBT solutions while lowering the total cost of ownership for high-voltage applications. The MSC035SMA070B4 device is a 700 V, 35 mΩ SiC MOSFET in a TO-247 package with a source sense.



Features

The following are key features of the MSC035SMA070B4 device:

- Low capacitances and low gate charge
- Fast switching speed due to low internal gate resistance (ESR)
- Stable operation at high junction temperature, $T_{J(max)} = 175\text{ }^{\circ}\text{C}$
- Fast and reliable body diode
- Superior avalanche ruggedness
- RoHS compliant

Benefits

The following are benefits of the MSC035SMA070B4 device:

- High efficiency to enable lighter, more compact system
- Simple to drive and easy to parallel
- Improved thermal capabilities and lower switching losses
- Eliminates the need for external freewheeling diode
- Lower system cost of ownership

Applications

The MSC035SMA070B4 device is designed for the following applications:

- PV inverter, converter, and industrial motor drives
- Smart grid transmission and distribution
- Induction heating and welding
- H/EV powertrain and EV charger
- Power supply and distribution

Device Specifications

This section shows the specifications of the MSC035SMA070B4 device.

Absolute Maximum Ratings

The following table shows the absolute maximum ratings of the MSC035SMA070B4 device.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
V _{DSS}	Drain source voltage	700	V
I _D	Continuous drain current at T _C = 25 °C	77	A
	Continuous drain current at T _C = 100 °C	54	
I _{DM}	Pulsed drain current ¹	192	
V _{GS}	Gate-source voltage	23 to -10	V
P _D	Total power dissipation at T _C = 25 °C	283	W
	Linear derating factor	1.9	W/°C

Note:

1. Repetitive rating: pulse width and case temperature limited by maximum junction temperature.

The following table shows the thermal and mechanical characteristics for the MSC035SMA070B4 device.

Table 2 • Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Typ	Max	Unit
R _{θJC}	Junction-to-case thermal resistance		0.38	0.53	°C/W
T _J	Operating junction temperature	-55		175	°C
T _{STG}	Storage temperature	-55		150	
T _L	Soldering temperature for 10 seconds (1.6 mm from case)			260	
	Mounting torque, 6-32 or M3 screw			10	lbf-in
				1.1	N-m
Wt	Package weight		0.22		oz
			6.2		g

Electrical Performance

The following table shows the static characteristics of the MSC035SMA070B4 device. $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Table 3 • Static Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	700			V
$R_{DS(on)}$	Drain-source on resistance ¹	$V_{GS} = 20\text{ V}, I_D = 30\text{ A}$		35	44	m Ω
$V_{GS(th)}$	Gate-source threshold voltage	$V_{GS} = V_{DS}, I_D = 2\text{ mA}$	1.9	2.7		V
$\Delta V_{GS(th)}/\Delta T_J$	Threshold voltage coefficient	$V_{GS} = V_{DS}, I_D = 2\text{ mA}$		-4.7		mV/ $^\circ\text{C}$
I_{DSS}	Zero gate voltage drain current	$V_{DS} = 700\text{ V}, V_{GS} = 0\text{ V}$			100	μA
		$V_{DS} = 700\text{ V}, V_{GS} = 0\text{ V}$ $T_J = 125\text{ }^\circ\text{C}$			500	
I_{GSS}	Gate-source leakage current	$V_{GS} = 20\text{ V}$			100	nA
		$V_{GS} = -10\text{ V}$			100	

Note:

1. Pulse test: pulse width < 380 μs , duty cycle < 2%.

The following table shows the dynamic characteristics of the MSC035SMA070B4 device. $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Table 4 • Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
C_{iss}	Input capacitance	$V_{GS} = 0\text{ V}, V_{DD} = 700\text{ V}$ $V_{AC} = 25\text{ mV}, f = 1\text{ MHz}$		2010		μF	
C_{rss}	Reverse transfer capacitance			17			
C_{oss}	Output capacitance			247			
Q_g	Total gate charge	$V_{GS} = -5\text{ V}/20\text{ V}, V_{DD} = 470\text{ V}$ $I_D = 30\text{ A}$		99		nC	
Q_{gs}	Gate-source charge			33			
Q_{gd}	Gate-drain charge			18			
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 470\text{ V}, V_{GS} = -5\text{ V}/20\text{ V},$ $I_D = 50\text{ A } R_{G(ext)} = 4.0\text{ }\Omega^1,$ Freewheeling diode = MSC050S-DA070B		12		ns	
t_r	Current rise time			9			
$t_{d(off)}$	Turn-off delay time			35			
t_f	Current fall time			21			
E_{on}^2	Turn-on switching energy			247			μJ
E_{off}	Turn-off switching energy			53			
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 470\text{ V}, V_{GS} = -5\text{ V}/20\text{ V},$ $I_D = 50\text{ A } R_{G(ext)} = 4.0\text{ }\Omega^1$ Freewheeling diode = MSC035S-MA070B4 ($V_{GS} = -5\text{ V}$)		10		ns	
t_r	Current rise time			9			
$t_{d(off)}$	Turn-off delay time			40			
t_f	Current fall time			52			
E_{on}^2	Turn-on switching energy			285			μJ
E_{off}	Turn-off switching energy			52			
ESR	Equivalent series resistance	$f = 1\text{ MHz}, 25\text{ mV}, \text{ drain short}$		1.13		Ω	
SCWT	Short circuit withstand time	$V_{DS} = 560\text{ V}, V_{GS} = 20\text{ V}$		3		μs	
E_{AS}	Avalanche energy, single pulse	$V_{DS} = 150\text{ V}, V_{GS} = 20\text{ V}, I_D = 30\text{ A}$		1400		mJ	

Notes:

1. R_G is total gate resistance excluding internal gate driver impedance.
2. E_{on} includes energy of freewheeling diode.

The following table shows the body diode characteristics of the MSC035SMA070B4 device.

Table 5 • Body Diode Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_{SD}	Diode forward voltage	$I_{SD} = 30\text{ A}, V_{GS} = 0\text{ V}$		3.8		V
		$I_{SD} = 30\text{ A}, V_{GS} = -5\text{ V}$		4.0		V
t_{rr}	Reverse recovery time	$I_{SD} = 30\text{ A}, V_{GS} = -5\text{ V}$ $V_{DD} = 470\text{ V}, dl/dt = -1000\text{ A}/\mu\text{s}$		75		ns
Q_{rr}	Reverse recovery charge			305		nC
I_{RRM}	Reverse recovery current			11		A

Typical Performance Curves

This section shows the typical performance curves of the MSC035SMA070B4 device.

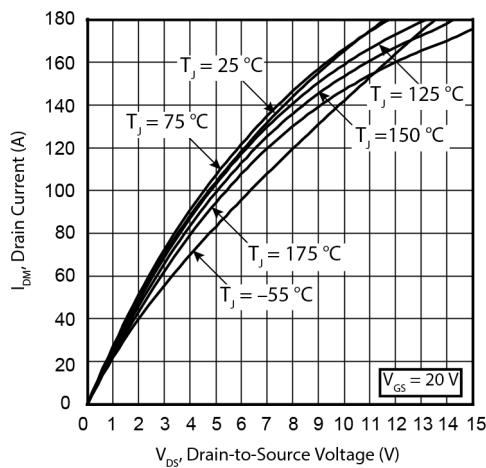


Figure 1 • Drain Current vs. V_{DS}

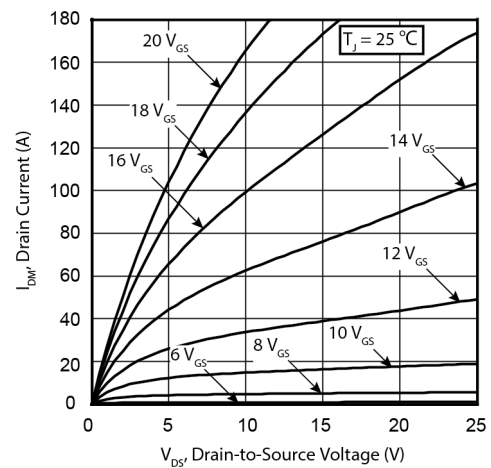


Figure 2 • Drain Current vs. V_{DS}

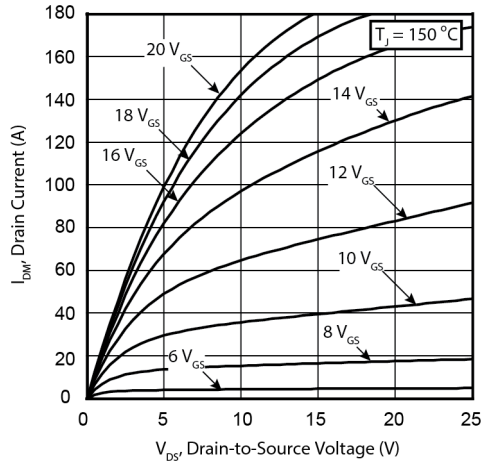


Figure 3 • Drain Current vs. V_{DS}

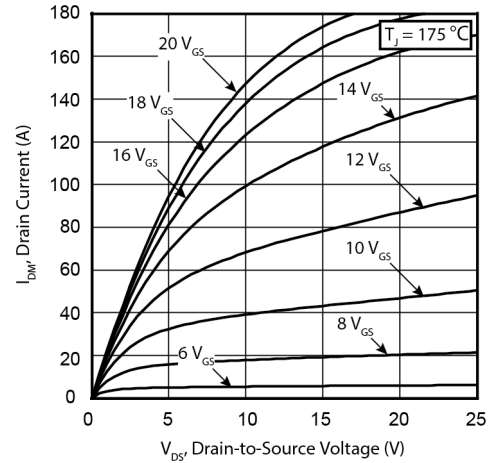


Figure 4 • Drain Current vs. V_{DS}

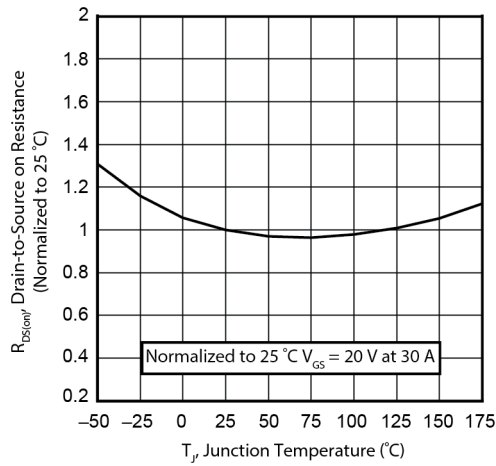


Figure 5 • $R_{DS(on)}$ vs. Junction Temperature

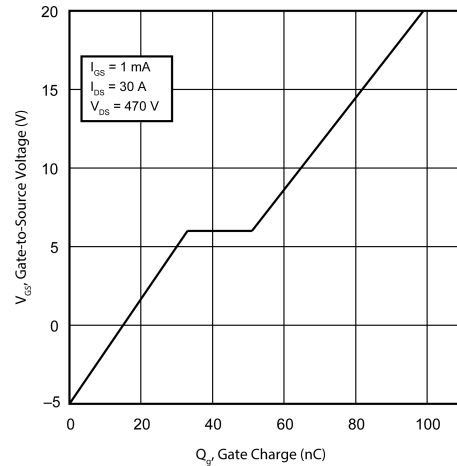


Figure 6 • Gate Charge Characteristics

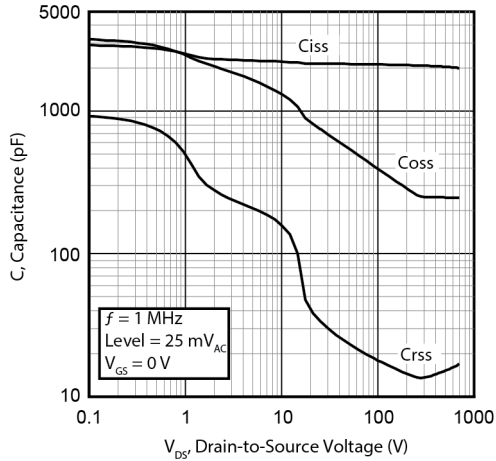


Figure 7 • Capacitance vs. V_{DS}

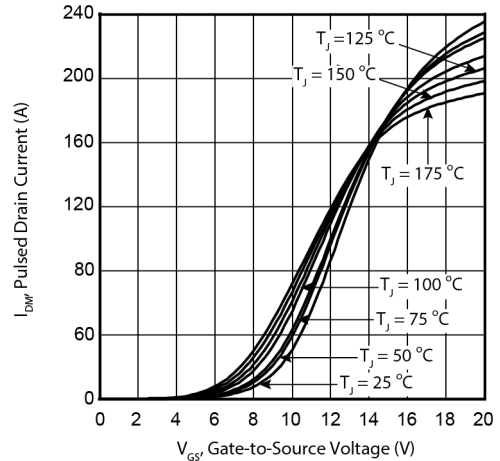


Figure 8 • I_{DM} vs. V_{GS}

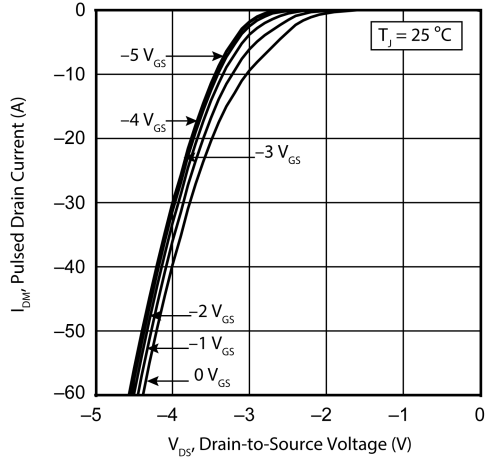


Figure 9 • I_{DM} vs. V_{DS} 3rd Quadrant Conduction

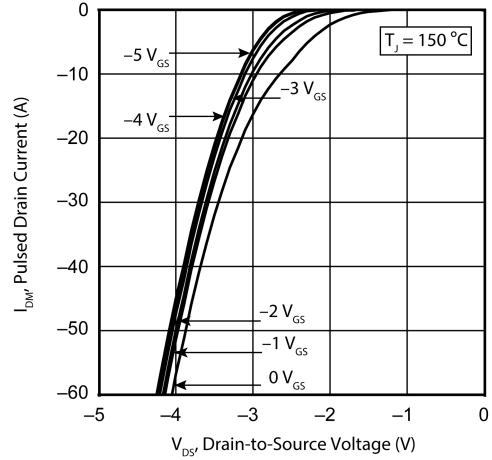


Figure 10 • I_{DM} vs. V_{DS} 3rd Quadrant Conduction

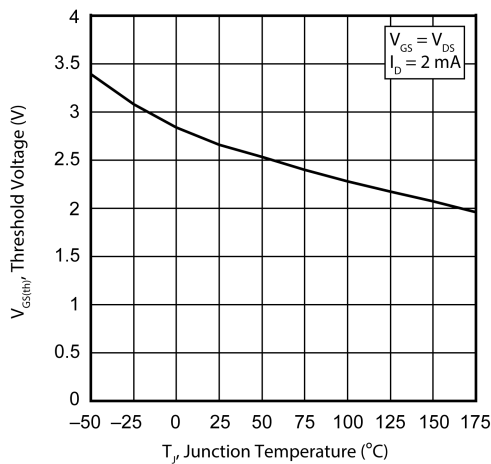


Figure 11 • $V_{GS(th)}$ vs. Junction Temperature

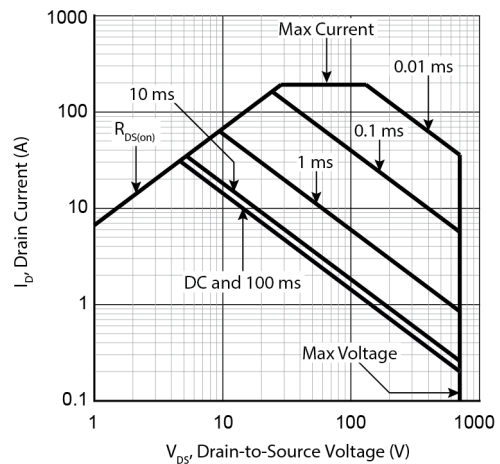


Figure 12 • Forward Safe Operating Area

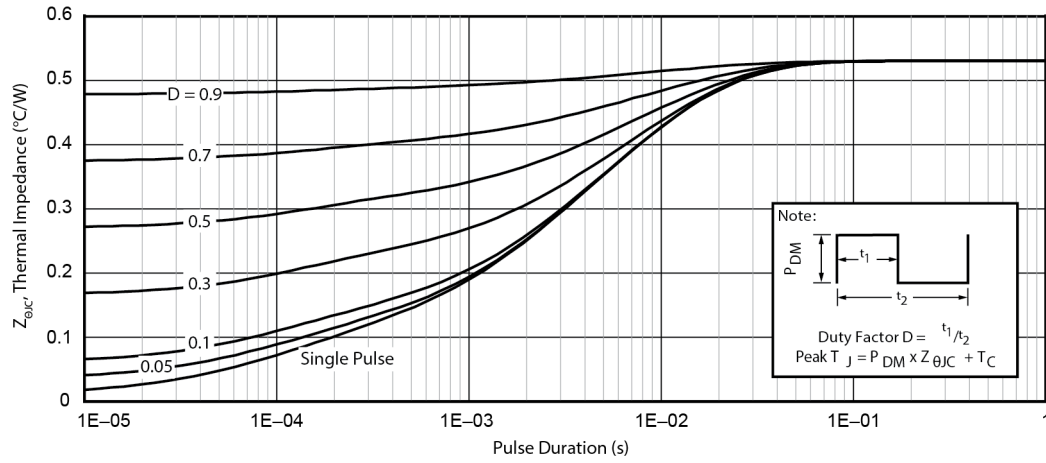


Figure 13 • Maximum Transient Thermal Impedance

Package Specification

This section shows the package specification of the MSC035SMA070B4 device.

Package Outline Drawing

The following figure illustrates the TO-247 package outline of the MSC035SMA070B4 device. The dimensions in the figure below are in millimeters and (inches).

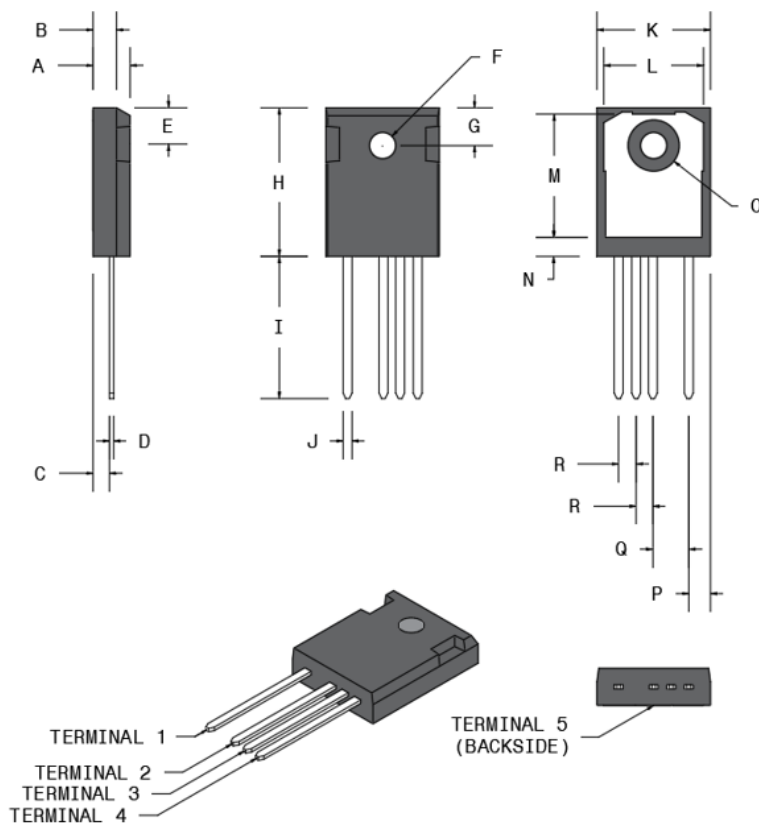


Figure 14 • Package Outline Drawing

The following table shows the TO-247 4-lead dimensions and should be used in conjunction with the package outline drawing.

Table 6 • TO-247-4L Dimensions

Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)
A	4.90	5.17	0.193	0.204
B	1.85	2.11	0.073	0.083
C	2.25	2.51	0.089	0.099
D	0.55	0.68	0.022	0.027
E	5.49	5.74	0.216	0.226

Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)
F	3.56	3.66	0.140	0.144
G	6.15 BSC		0.242 BSC	
H	20.83	21.08	0.820	0.830
I	19.81	20.32	0.780	0.800
J	1.07	1.33	0.042	0.052
K	15.77	16.03	0.621	0.631
L	13.89	14.15	0.547	0.557
M	16.25	16.85	0.640	0.663
N	2.00	2.75	0.079	0.108
O	7.10	7.50	0.280	0.295
P	2.87 BSC		0.113 BSC	
Q	5.08 BSC		0.200 BSC	
R	2.54 BSC		0.100 BSC	
Terminal 1	Drain			
Terminal 2	Source			
Terminal 3	Source sense			
Terminal 4	Gate			
Terminal 5	Drain			

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